

NGTB20N135IHRWG

IGBT with Monolithic Free Wheeling Diode

This Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Field Stop (FS) Trench construction, and provides superior performance in demanding switching applications, offering both low on-state voltage and minimal switching loss. The IGBT is well suited for resonant or soft switching applications.

Features

- Extremely Efficient Trench with Fieldstop Technology
- 1350 V Breakdown Voltage
- Optimized for Low Losses in IH Cooker Application
- Reliable and Cost Effective Single Die Solution
- These are Pb-Free Devices

Typical Applications

- Inductive Heating
- Consumer Appliances
- Soft Switching

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-emitter voltage	V_{CES}	1350	V
Collector current @ $T_c = 25^\circ\text{C}$ @ $T_c = 100^\circ\text{C}$	I_C	40 20	A
Pulsed collector current, T_{pulse} limited by T_{Jmax} , 10 μs Pulse, $V_{GE} = 15$ V	I_{CM}	120	A
Diode forward current @ $T_c = 25^\circ\text{C}$ @ $T_c = 100^\circ\text{C}$	I_F	40 20	A
Diode pulsed current, T_{pulse} limited by T_{Jmax} , 10 μs Pulse, $V_{GE} = 0$ V	I_{FM}	120	A
Gate-emitter voltage Transient Gate-emitter Voltage ($T_{pulse} = 5$ μs , $D < 0.10$)	V_{GE}	± 20 ± 25	V
Power Dissipation @ $T_c = 25^\circ\text{C}$ @ $T_c = 100^\circ\text{C}$	P_D	394 197	W
Operating junction temperature range	T_J	-40 to +175	$^\circ\text{C}$
Storage temperature range	T_{stg}	-55 to +175	$^\circ\text{C}$
Lead temperature for soldering, 1/8" from case for 5 seconds	T_{SLD}	260	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



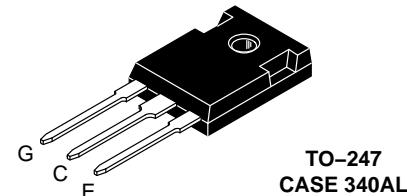
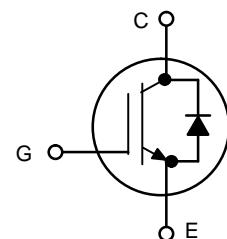
ON Semiconductor®

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20 A, 1350 V

$V_{CEsat} = 2.20$ V

$E_{off} = 0.60$ mJ



MARKING DIAGRAM



A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
NGTB20N135IHRWG	TO-247 (Pb-Free)	30 Units / Rail

NGTB20N135IHRWG

THERMAL CHARACTERISTICS

Rating	Symbol	Value	Unit
Thermal resistance junction-to-case	$R_{\theta JC}$	0.38	°C/W
Thermal resistance junction-to-ambient	$R_{\theta JA}$	40	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
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STATIC CHARACTERISTIC

Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V}, I_C = 5 \text{ mA}$	$V_{(BR)CES}$	1350	–	–	V
Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 20 \text{ A}$ $V_{GE} = 15 \text{ V}, I_C = 20 \text{ A}, T_J = 175^\circ\text{C}$	V_{CEsat}	– –	2.20 2.40	2.65 –	V
Gate-emitter threshold voltage	$V_{GE} = V_{CE}, I_C = 250 \mu\text{A}$	$V_{GE(th)}$	4.5	5.5	6.5	V
Collector-emitter cut-off current, gate-emitter short-circuited	$V_{GE} = 0 \text{ V}, V_{CE} = 1350 \text{ V}$ $V_{GE} = 0 \text{ V}, V_{CE} = 1350 \text{ V}, T_J = 175^\circ\text{C}$	I_{CES}	– –	– –	0.5 2.0	mA
Gate leakage current, collector-emitter short-circuited	$V_{GE} = 20 \text{ V}, V_{CE} = 0 \text{ V}$	I_{GES}	–	–	100	nA

DYNAMIC CHARACTERISTIC

Input capacitance	$V_{CE} = 20 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$	C_{ies}	–	5290	–	pF
Output capacitance		C_{oes}	–	124	–	
Reverse transfer capacitance		C_{res}	–	100	–	
Gate charge total	$V_{CE} = 600 \text{ V}, I_C = 20 \text{ A}, V_{GE} = 15 \text{ V}$	Q_g	–	234	–	nC
Gate to emitter charge		Q_{ge}	–	39	–	
Gate to collector charge		Q_{gc}	–	105	–	

SWITCHING CHARACTERISTIC, INDUCTIVE LOAD

Turn-off delay time	$T_J = 25^\circ\text{C}$ $V_{CC} = 600 \text{ V}, I_C = 20 \text{ A}$ $R_g = 10 \Omega$ $V_{GE} = 0 \text{ V}/15\text{V}$	$t_{d(off)}$	–	245	–	ns
Fall time		t_f	–	175	–	
Turn-off switching loss		E_{off}	–	0.60	–	mJ
Turn-off delay time	$T_J = 150^\circ\text{C}$ $V_{CC} = 600 \text{ V}, I_C = 20 \text{ A}$ $R_g = 10 \Omega$ $V_{GE} = 0 \text{ V}/15\text{V}$	$t_{d(off)}$	–	270	–	ns
Fall time		t_f	–	290	–	
Turn-off switching loss		E_{off}	–	1.40	–	mJ

DIODE CHARACTERISTIC

Forward voltage	$V_{GE} = 0 \text{ V}, I_F = 20 \text{ A}$ $V_{GE} = 0 \text{ V}, I_F = 20 \text{ A}, T_J = 175^\circ\text{C}$	V_F	– –	1.80 2.70	2.10 –	V
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Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

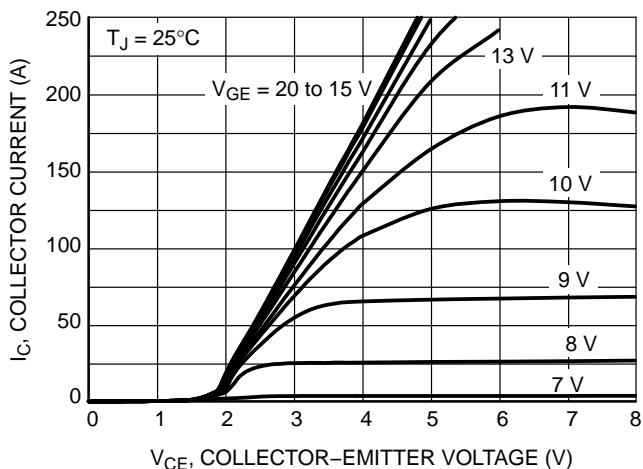


Figure 1. Output Characteristics

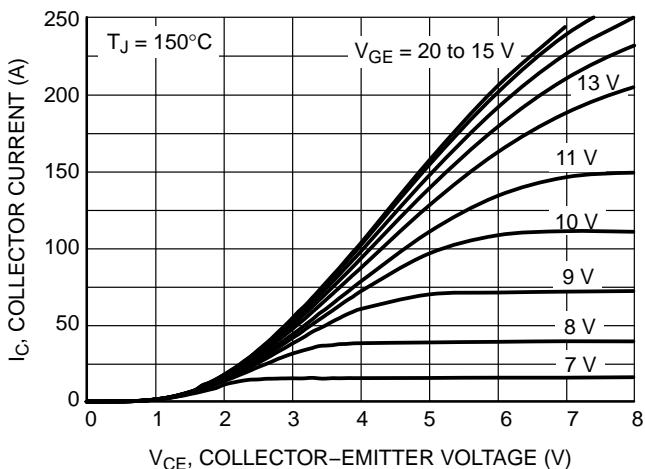


Figure 2. Output Characteristics

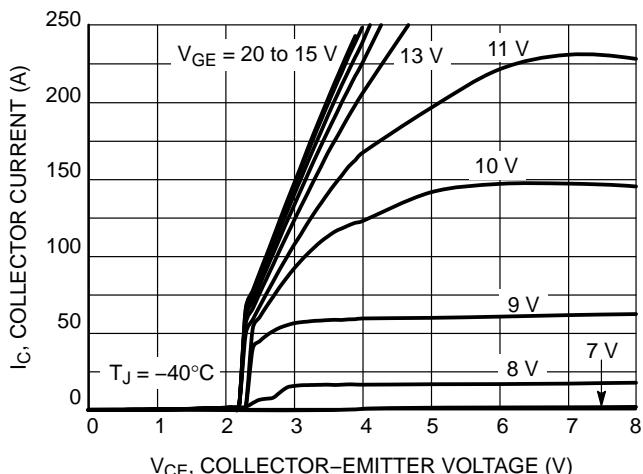


Figure 3. Output Characteristics

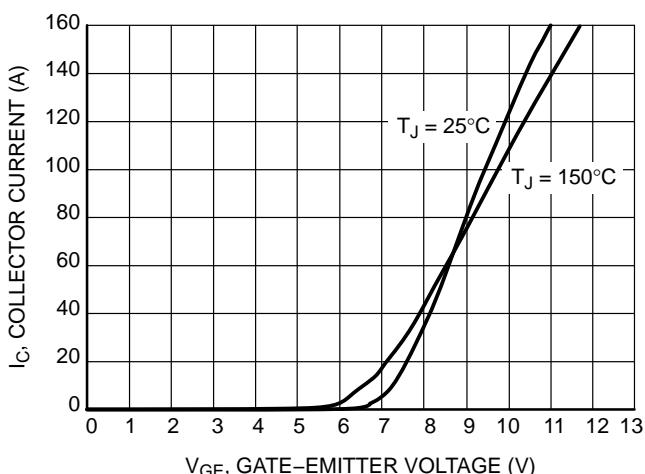


Figure 4. Typical Transfer Characteristics

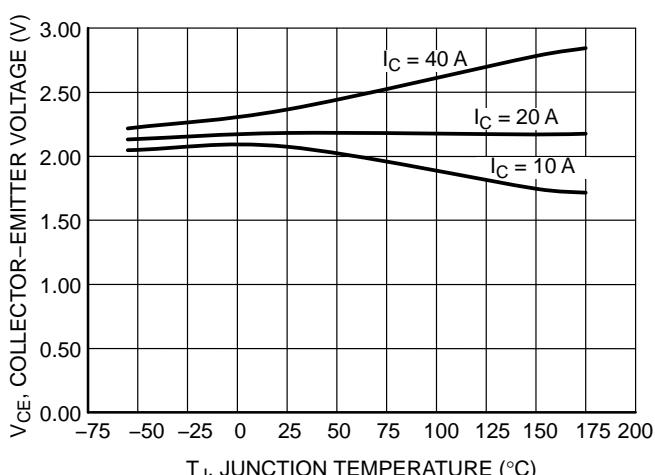
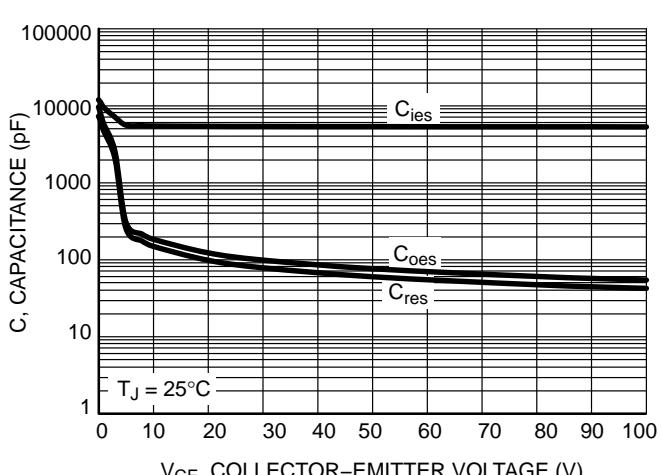
Figure 5. $V_{CE(sat)}$ vs. T_J 

Figure 6. Typical Capacitance

TYPICAL CHARACTERISTICS

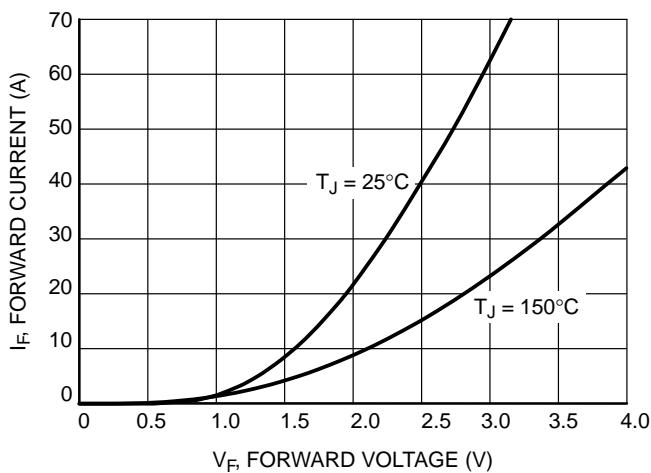


Figure 7. Diode Forward Characteristics

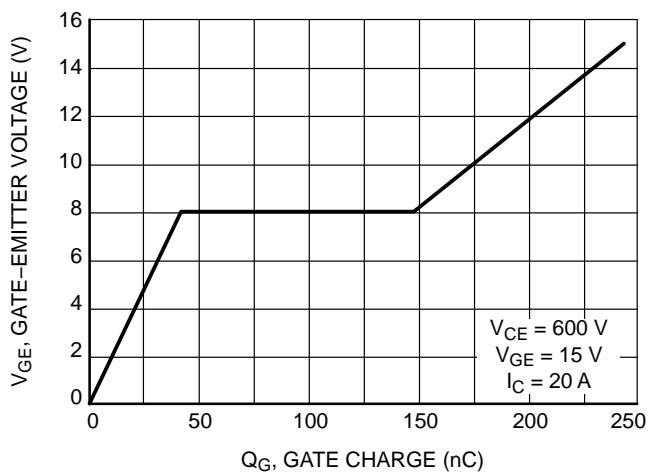


Figure 8. Typical Gate Charge

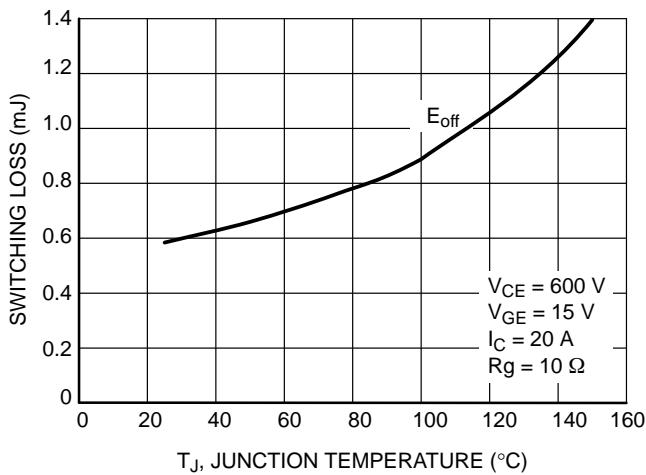


Figure 9. Switching Loss vs. Temperature

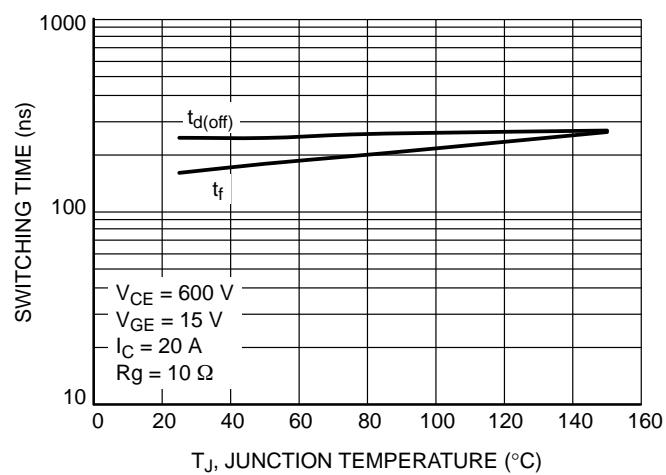
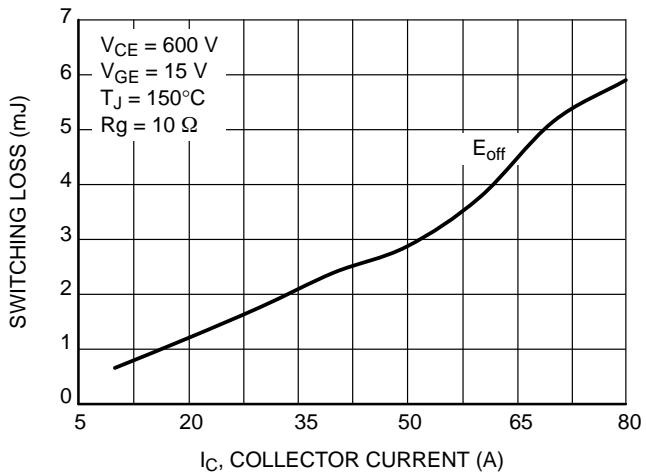
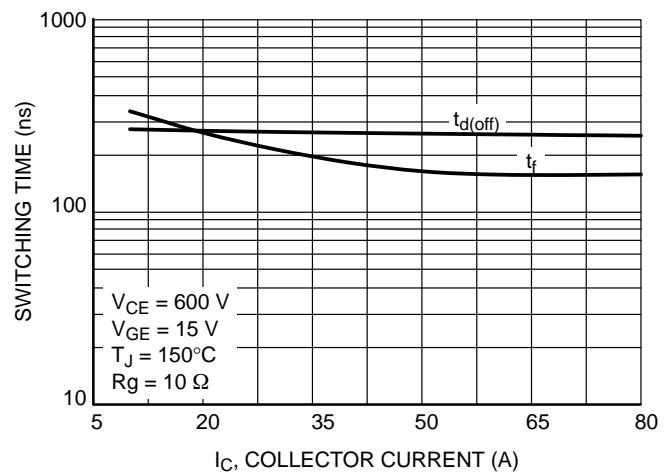


Figure 10. Switching Time vs. Temperature

Figure 11. Switching Loss vs. I_C Figure 12. Switching Time vs. I_C

TYPICAL CHARACTERISTICS

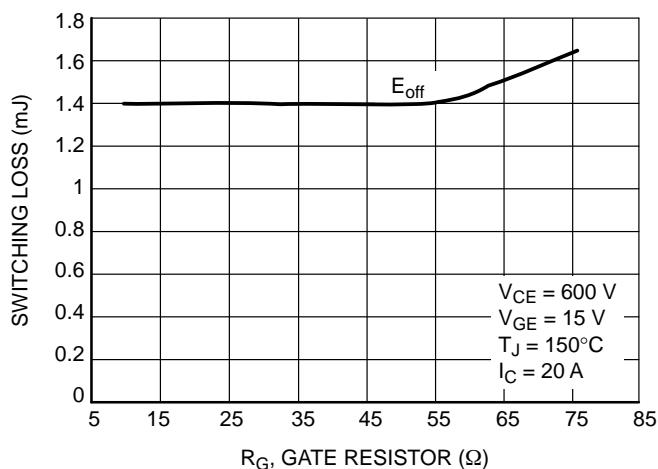


Figure 13. Switching Loss vs. R_g

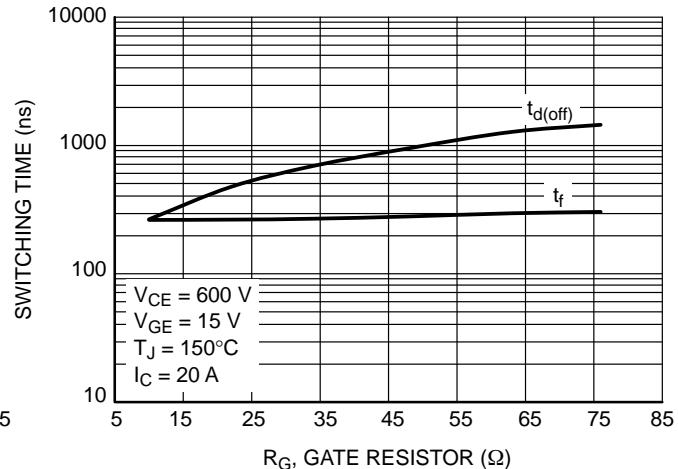


Figure 14. Switching Time vs. R_g

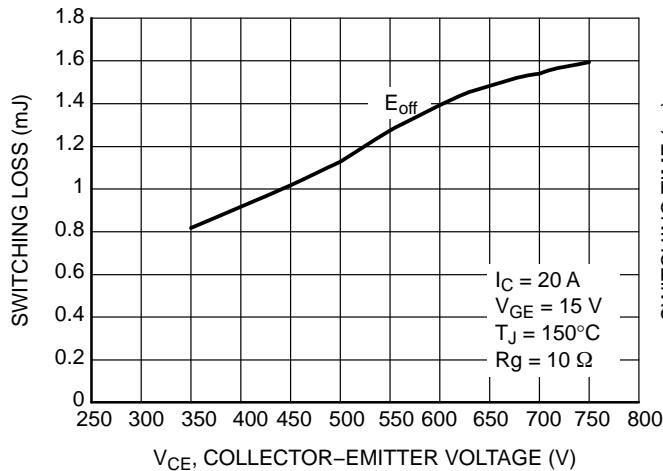


Figure 15. Switching Loss vs. V_{CE}

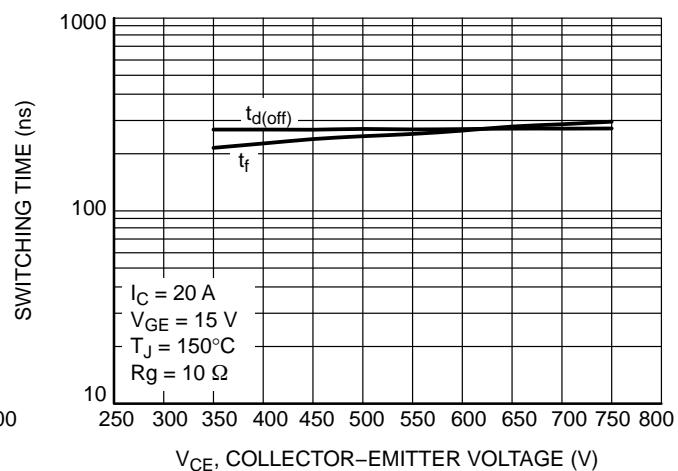


Figure 16. Switching Time vs. V_{CE}

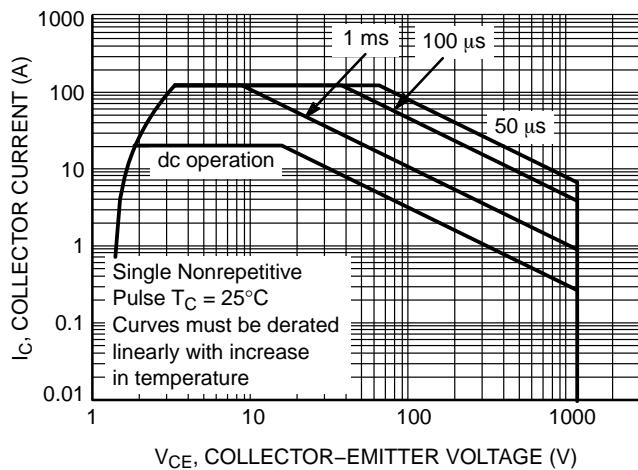


Figure 17. Safe Operating Area

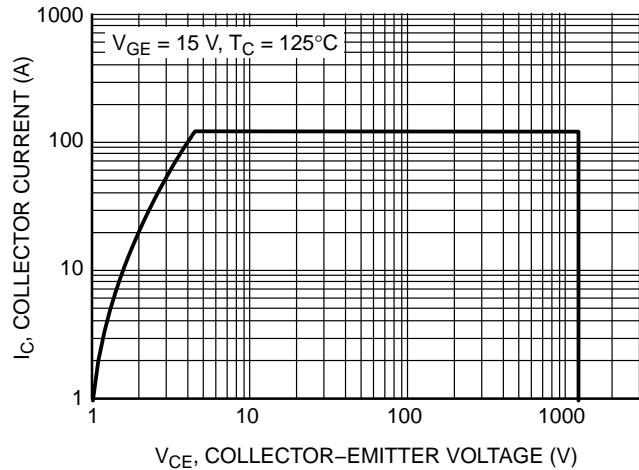
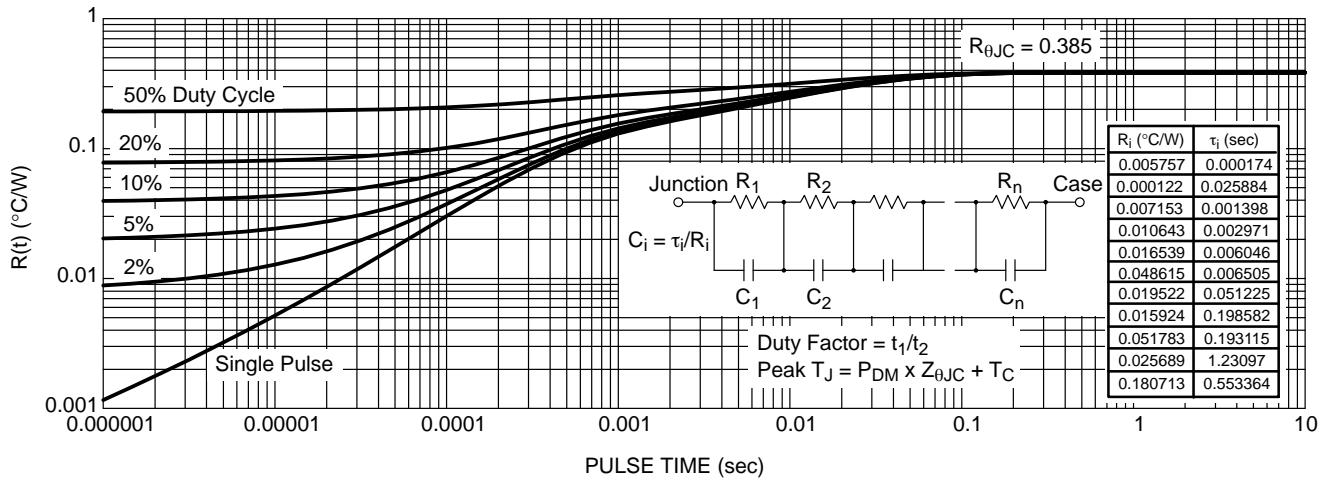
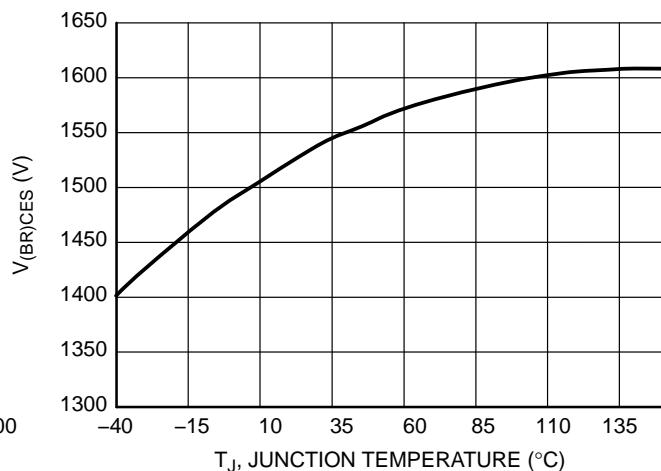
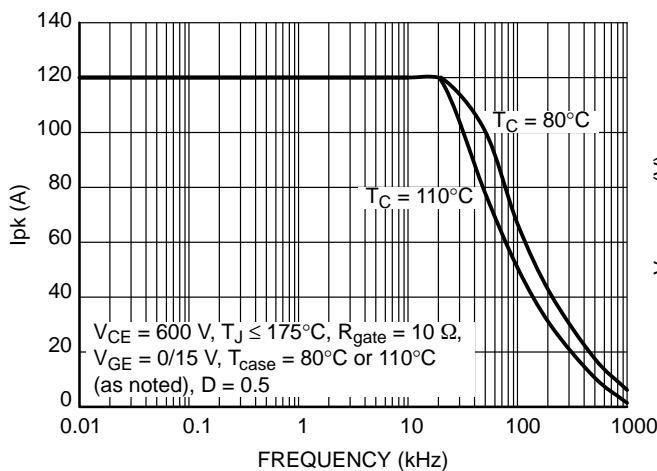


Figure 18. Reverse Bias Safe Operating Area

TYPICAL CHARACTERISTICS



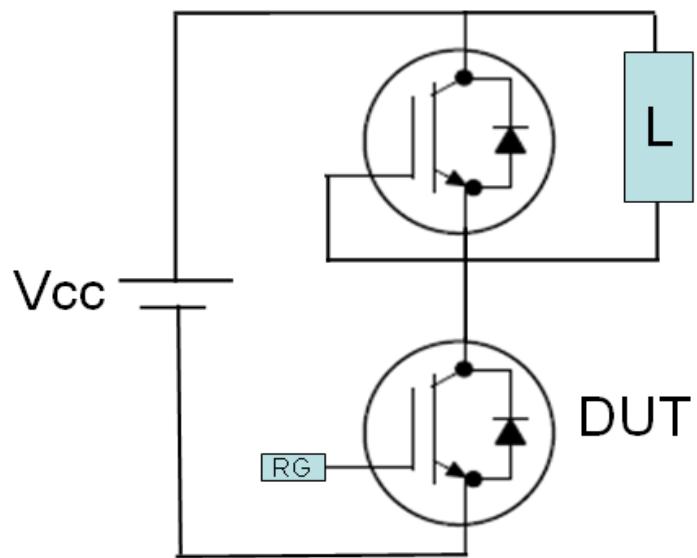


Figure 22. Test Circuit for Switching Characteristics

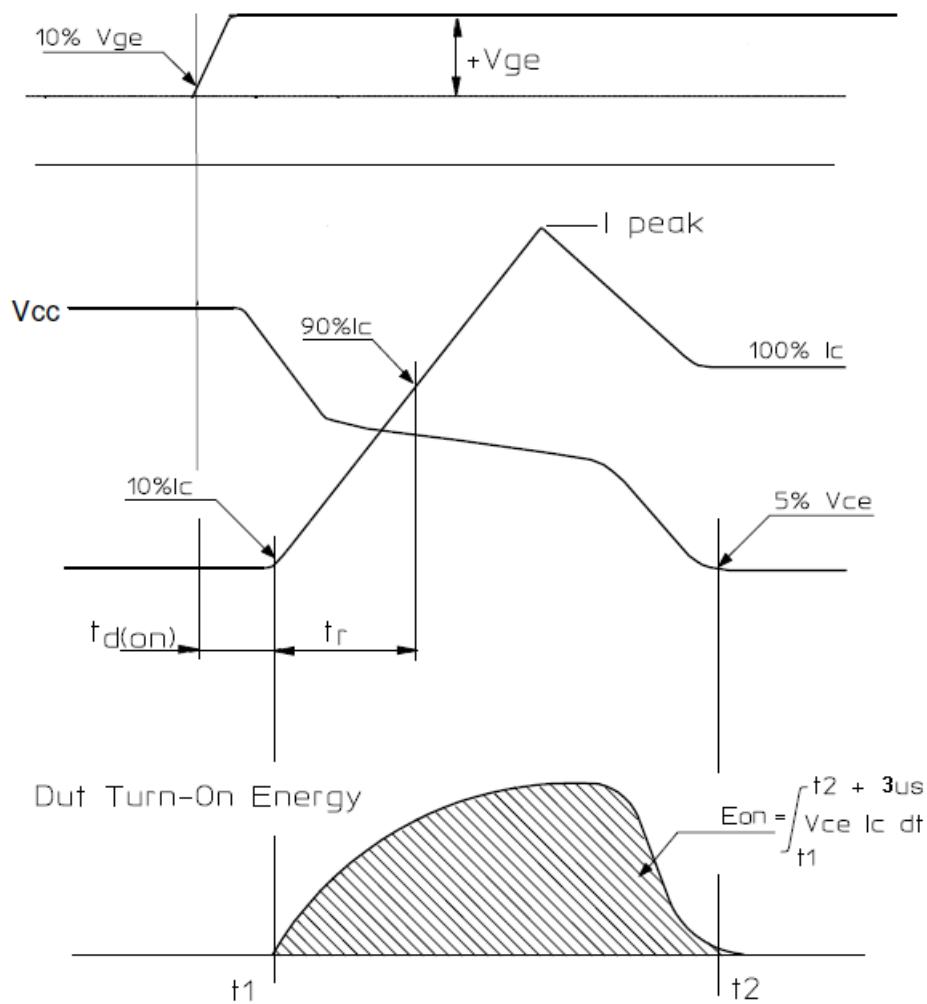


Figure 23. Definition of Turn On Waveform

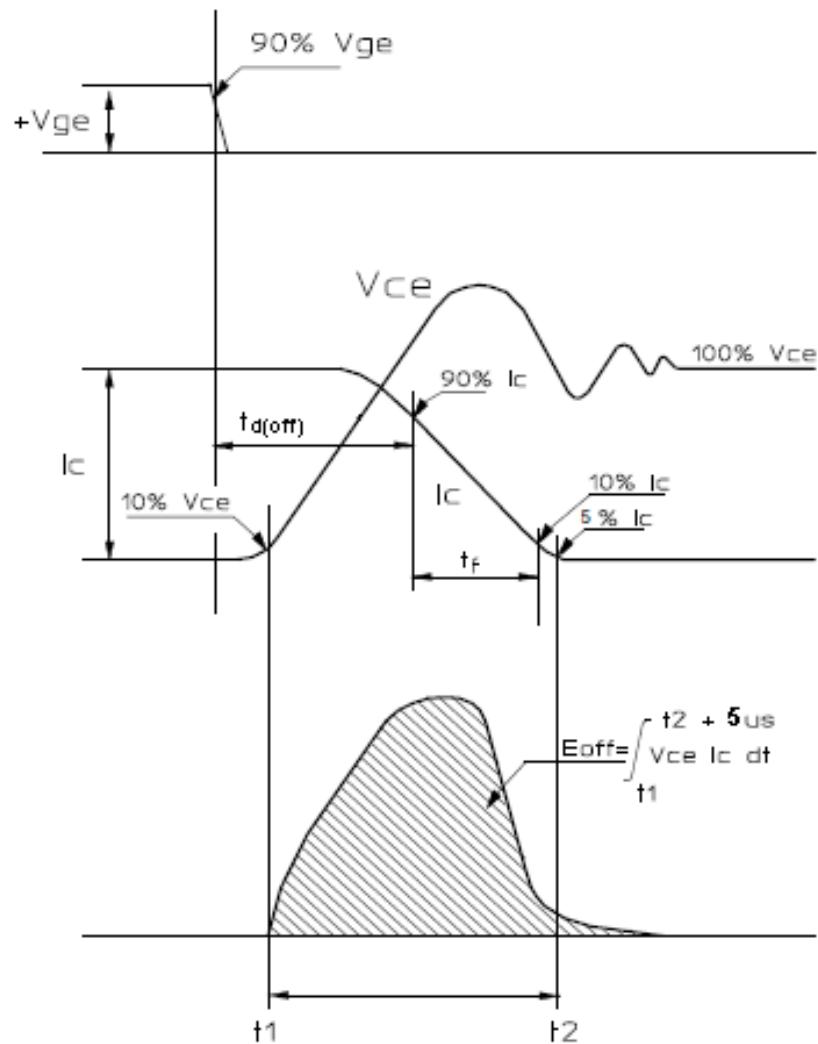
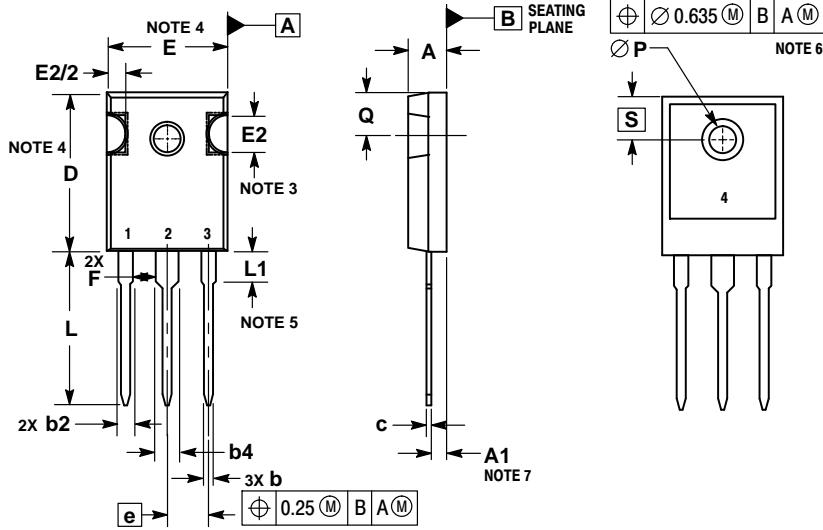


Figure 24. Definition of Turn Off Waveform

PACKAGE DIMENSIONS

TO-247
CASE 340AL
ISSUE D

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. SLOT REQUIRED, NOTCH MAY BE ROUNDED.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREME OF THE PLASTIC BODY.
5. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.
6. ØP SHALL HAVE A MAXIMUM DRAFT ANGLE OF 1.5° TO THE TOP OF THE PART WITH A MAXIMUM DIAMETER OF 3.91.
7. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.

DIM	MILLIMETERS	
	MIN	MAX
A	4.70	5.30
A1	2.20	2.60
b	1.07	1.33
b2	1.65	2.35
b4	2.60	3.40
c	0.45	0.68
D	20.80	21.34
E	15.50	16.25
E2	4.32	5.49
e	5.45 BSC	
F	2.655	---
L	19.80	20.80
L1	3.81	4.32
P	3.55	3.65
Q	5.40	6.20
S	6.15 BSC	

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